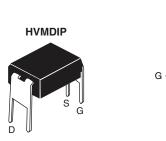
COMPLIANT



Power MOSFET





PRODUCT SUMMARY					
V _{DS} (V)	100				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.54			
Q _g (Max.) (nC)	8.3				
Q _{gs} (nC)	2.3				
Q _{gd} (nC)	3.8				
Configuration	Single				

FEATURES

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · For automatic insertion
- End stackable
- 175 °C Operating Temperature
- · Fast switching and ease of paralleling
- · Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION					
Package	HVMDIP				
Lead (Pb)-free	IRFD110PbF				

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-source voltage	V_{DS}	100	V			
Gate-source voltage	V_{GS}	± 20	V			
Continuous drain current	V_{GS} at 10 V $T_A = 25 ^{\circ}\text{C}$ $T_A = 100 ^{\circ}\text{C}$	- I _D	1.0			
	V_{GS} at 10 V $T_A = 100 ^{\circ}C$		0.71	Α		
Pulsed drain current ^a	I _{DM}	8.0				
Linear derating factor		0.0083	W/°C			
Single pulse avalanche energy b	E _{AS}	140	mJ			
Repetitive avalanche current a	I _{AR}	1.0	Α			
Repetitive avalanche energy ^a	E _{AR}	0.13	mJ			
Maximum power dissipation $T_A = 25 ^{\circ}\text{C}$		P _D	1.3	W		
Peak diode recovery dV/dt ^c		dV/dt	5.5	V/ns		
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +175	°C			
Soldering recommendations (peak temperature)	For 10 s		300 ^d			

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 52 \,^{\circ}\text{mH}$, $R_g = 25 \,^{\circ}\Omega$, $I_{AS} = 2.0 \,^{\circ}\text{A}$ (see fig. 12)
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.12	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zana Oata Waltana Duain Ourmant		V _{DS} =	V _{DS} = 100 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.60 A ^b	-	-	0.54	Ω
Forward Transconductance	9fs	V _{DS} = 50 V, I _D = 0.60 A ^b		0.80	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	180	-	
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$		81	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	15	-	1
Total Gate Charge	Qg		-	-	8.3		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b		-	2.3	nC
Gate-Drain Charge	Q _{gd}	1			-	3.8	
Turn-On Delay Time	t _{d(on)}				6.9	-	- ns
Rise Time	t _r	V_{DD} = 50 V, I_D = 5.6 A, R_g = 24 Ω , R_D = 8.4 Ω , see fig. 10 ^b		-	16	-	
Turn-Off Delay Time	t _{d(off)}			-	15	-	
Fall Time	t _f			-	9.4	-	
Internal Drain Inductance	L _D	6 mm (0.25") t	Between lead, 6 mm (0.25") from		4.0	-	n I I
Internal Source Inductance	L _S	package and center of die contact		-	6.0	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.0	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.0	, ,
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 1.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.6 A, dI/dt = 100 A/μs ^b		-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			_	0.44	0.88	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

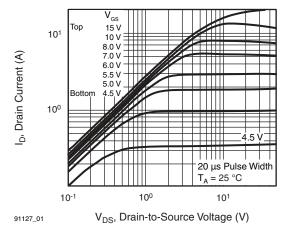


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

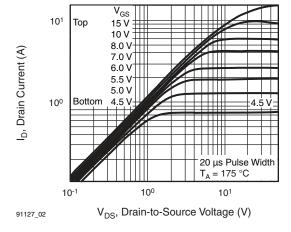


Fig. 2 - Typical Output Characteristics, T_A = 175 °C

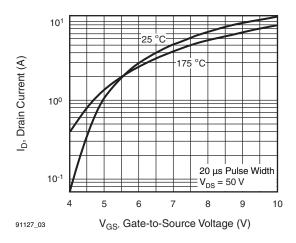


Fig. 3 - Typical Transfer Characteristics

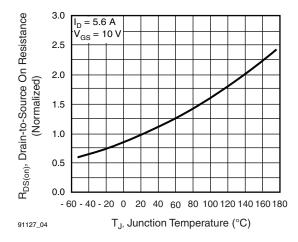


Fig. 4 - Normalized On-Resistance vs. Temperature



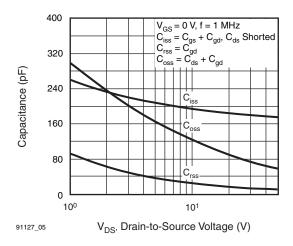


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

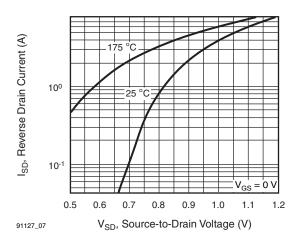


Fig. 7 - Typical Source-Drain Diode Forward Voltage

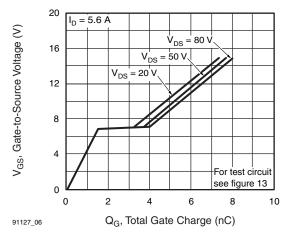


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

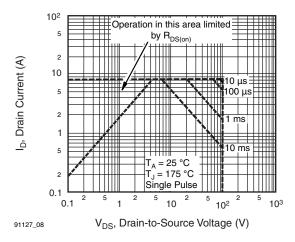


Fig. 8 - Maximum Safe Operating Area



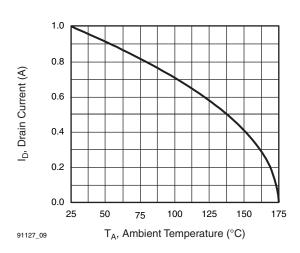


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

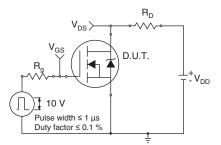


Fig. 10a - Switching Time Test Circuit

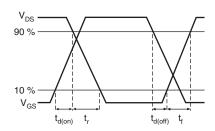


Fig. 10b - Switching Time Waveforms

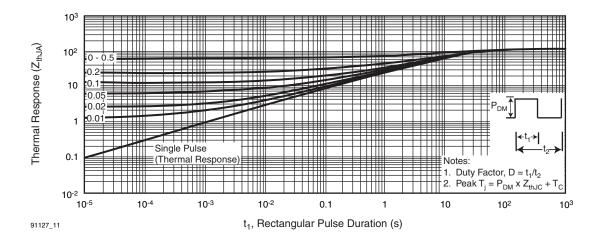


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



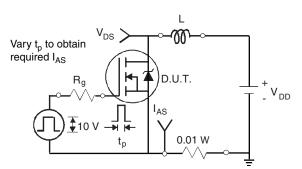


Fig. 12a - Unclamped Inductive Test Circuit

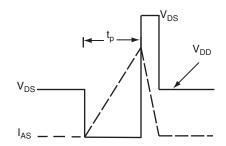


Fig. 12b - Unclamped Inductive Waveforms

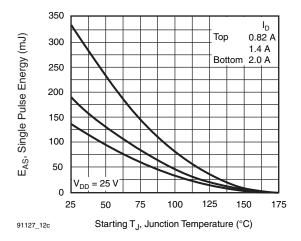


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

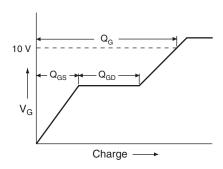


Fig. 13a - Basic Gate Charge Waveform

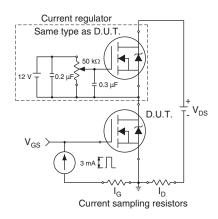
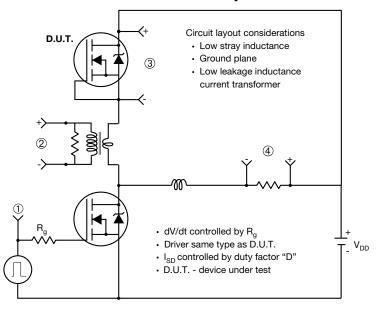


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



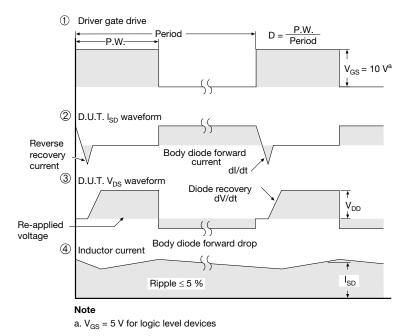


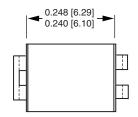
Fig. 14 - For N-Channel

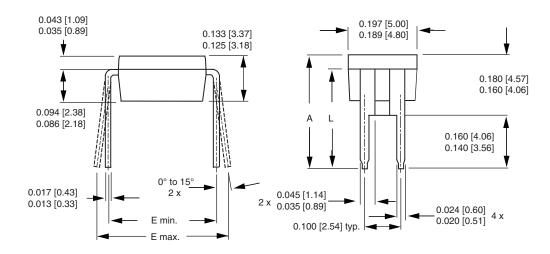
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HVM DIP (High voltage)





	INCHES		MILLIMETERS	
DIM.	MIN.	MAX.	MIN.	MAX.
A	0.310	0.330	7.87	8.38
Е	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

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Revision: 06-Sep-10 1



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